

**Notice of References Cited**

Application/Control No.

09/762,630

Applicant(s)/Patent Under  
Reexamination  
EMBIL ET AL.

Examiner

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Art Unit

1614

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,744,458	04-1998	Kruse et al.	514/91
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

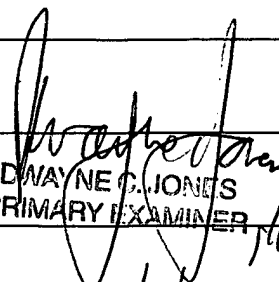
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	N	EP 812587 A1	12-1997	European Patent	JAIN et al.	A61K 09/20
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	P					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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